



中国认可  
国际互认  
检测  
TESTING  
CNAS L0310



# FCC

# RF Test Report

**Product Name: Smart Phone**

**Model Number: EVA-L09**

**Report No: SYBH(Z-RF)013122015-2004**

**FCC ID: QISEVA-L09**

**Reliability Laboratory of Huawei Technologies Co., Ltd.**

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## Notice

1. The laboratory has Passed the accreditation by China National Accreditation Service for Conformity Assessment (CNAS). The accreditation number is L0310.
2. The laboratory has Passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01.
3. The laboratory has been listed by the US Federal Communications Commission to perform electromagnetic emission measurements. The site recognition number is 97456.
4. The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 6369A-1.
5. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
6. The test report is invalid if there is any evidence of erasure and/or falsification.
7. The test report is only valid for the test samples.
8. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
9. The laboratory (Reliability Lab of Huawei Technologies Co., Ltd) is also named as “Global Compliance and Testing Center of Huawei Technologies Co., Ltd”, the both names have coexisted since 2009.



**Applicant:** Huawei Technologies Co., Ltd.  
**Address:** Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

**Date of Receipt Sample:** 2015-12-14  
**Start Date of Test:** 2015-12-15  
**End Date of Test:** 2016-02-05

**Test Result:** Pass

**Approved by Senior** 2016-02-19 Liu Chunlin   
**Engineer:** Date Name Signature

**Prepared by:** 2016-02-18 maowenli   
Date Name Signature

**Modification Record**

No.	Last Report No.	Modification Description
1		First report.



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## 1 General Information

### 1.1 Applied Standard

Applied Rules: 47 CFR FCC Part 2, Subpart J 2014  
47 CFR FCC Part 15, Subpart C 2014

Test Method: FCC KDB 558074 D01 DTS Meas Guidance v03r02  
ANSI C63.10-2013, American National Standard for Testing Unlicensed  
Wireless Devices.

### 1.2 Test Location

Test Location 1: Reliability Laboratory of Huawei Technologies Co., Ltd.  
Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,  
Bantian, Longgang District, Shenzhen, 518129, P.R.C

### 1.3 Test Environment Condition

Ambient Temperature: 19.5 to 25 °C  
Ambient Relative Humidity: 40 to 55 %  
Atmospheric Pressure: Not applicable



## 2 Test Summary

Test Item	FCC Part No.	Requirements	Test Result	Verdict
DTS (6 dB) Bandwidth	15.247(a)(2)	$\geq 500$ kHz.	Appendix A	Pass
Occupied Bandwidth	---	No limit	Appendix B	Pass
Duty Cycle	KDB 558074 (6.0)	No limit	Appendix C	Pass
Maximum Conducted Average Output Power	15.247(b)(3)	For directional gain: $< 30$ dBm – (G[dBi] – 6 [dB]), Average; Otherwise: $< 30$ dBm, Average.	Appendix D	Pass
Maximum Power Spectral Density Level	15.247(e)	For directional gain: $< 8$ dBm/3 kHz – (G[dBi] – 6 [dB]), Average. Otherwise: $< 8$ dBm/3 kHz, Average.	Appendix E	Pass
Band Edges Compliance	15.247(d)	< -30 dB <sub>r</sub> /100 kHz if total average power $\leq$ power limit.	Appendix F	Pass
Unwanted Emissions into Non-Restricted Frequency Bands			Appendix G	Pass
Unwanted Emissions into Restricted Frequency Bands (Radiated)	15.247(d) 15.209 (NOTE 1)	FCC Part 15.209 field strength limit; RSS-Gen 6.13 field strength limit.	Appendix H	Pass
AC Power Line Conducted Emissions	15.207	FCC Part 15.207 conducted limit; RSS-Gen, 6.13 conducted limit.	Appendix I	Pass
NOTE 1: According to KDB 558074, antenna-port conducted measurements are acceptable as an alternative to radiated measurements for demonstrating compliance to the limits in the restricted frequency bands. If conducted measurements are performed, then proper impedance matching must be ensured and an additional radiated test for cabinet/case emissions will also be required.				



### 3 Description of the Equipment under Test (EUT)

#### 3.1 General Description

EVA-L09 is subscriber equipment in the LTE/WCDMA /GSM system. The LTE frequency band is Band I,Band II,Band III,Band IV,Band V, Band VI ,Band VII,Band VIII, Band XII,Band XVII, Band XVIII ,Band XIX, Band XX, Band XXVI, Band XXVIII ,Band XXXVIII,BandXXXIX, Band XL and Band XLI. The HSUPA/HSDPA/ UMTS frequency band is Band I, Band II, Band IV, Band V, Band VI, Band VIII and Band XIX, The GSM/GPRS/EDGE frequency band includes GSM850 and GSM900 and DCS1800 and PCS1900, The Mobile Phone implements such functions as RF signal receiving/transmitting, LTE/ WCDMA /GSM protocol processing, voice, video, MMS service, GPS, AGPS,NFC and WIFI etc. Externally it provides earphone port (to provide voice service) and USIM card interface. It also provides Bluetooth module to synchronize data between a PC and the phone, or to use the built-in modem of the phone to access the Internet with a PC, or to exchange data with other Bluetooth devices.

NOTE:

Only BLE test data included in this report

#### 3.2 EUT Identity

NOTE: Unless otherwise noted in the report, the functional boards installed in the units shall be selected from the below list, but not means all the functional boards listed below shall be installed in one unit.

##### 3.2.1 Board

Board		
Description	Hardware Version	Software Version
Main Board	HL1LEVAM	A168-L09C900B071

##### 3.2.2 Sub- Assembly

Sub-Assembly			
Sub-Assembly Name	Model	Manufacturer	Description
Adapter	HW-050200U01	Huawei Technologies Co., Ltd.	Input Voltage: ~100-240V 50/60Hz 0.5A Output Voltage: 5V 2A Rated Power: 10W
Adapter	HW-050200E01	Huawei Technologies Co., Ltd.	Input Voltage: ~100-240V 50/60Hz 0.5A Output Voltage: 5V 2A Rated Power: 10W
Adapter	HW-050200B01	Huawei Technologies Co., Ltd.	Input Voltage: ~100-240V 50/60Hz 0.5A Output Voltage: 5V 2A Rated Power: 10W
Adapter	HW-050200A01	Huawei Technologies	Input Voltage: ~100-240V 50/60Hz 0.5A



Sub-Assembly			
Sub-Assembly Name	Model	Manufacturer	Description
		Co., Ltd.	Output Voltage: 5V <del>====</del> 2A Rated Power: 10W
Battery	HB366481ECW	Huawei Technologies Co., Ltd.	Rated capacity: 2900mAh Nominal Voltage: <del>====</del> +3.8V Charging Voltage: <del>====</del> +4.4V

### 3.3 Technical Description

Characteristics	Description	
TX/RX Operating Range	2400-2483.5 MHz band	fc = 2402 MHz + N * 2 MHz, where: - fc = "Operating Frequency" in MHz, - N = "Channel Number" with the range from 0 to 39.
Modulation Type	Digital	GFSK,
Emission Designator	GFSK for BT 4.0: 720KGXD	
Bluetooth Power Class	Class 1	



## 4 General Test Conditions / Configurations

### 4.1 EUT Configurations

#### 4.1.1 General Configurations

Configuration	Description
Test Antenna Ports	Until otherwise specified, - All TX tests are performed at all TX antenna ports of the EUT, and - All RX tests are performed at all RX antenna ports of the EUT.
Multiple RF Sources	Other than the tested RF source of the EUT, other RF source(s) are disabled or shutdown during measurements.

#### 4.1.2 Customized Configurations

# EUT Conf.	Signal Description	Operating Frequency	Duty cycle
BLE-MCH	GFSK for BT 4.0 modulation, package type DH5, hopping off.	Ch No. 0 / 2440 MHz	61.6%

### 4.2 Test Environments

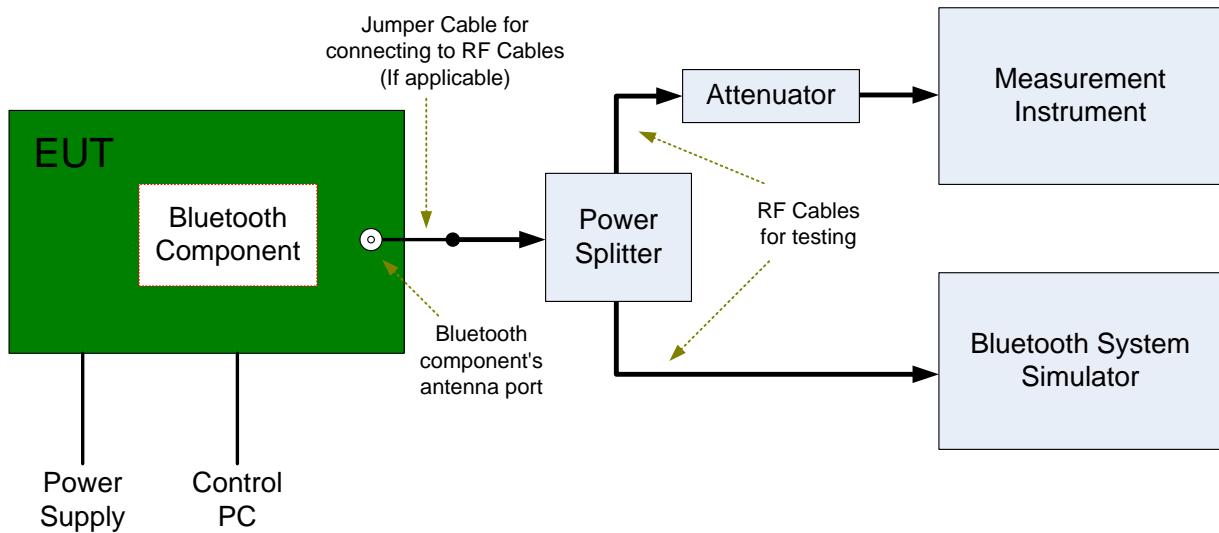
NOTE: The values used in the test report may be stringent than the declared.

Environment Parameter	Selected Values During Tests		
	Temperature	Voltage	Relative Humidity
NTNV	Ambient	3.8 VDC	Ambient

## 4.3 Test Setups

### 4.3.1 Test Setup 1

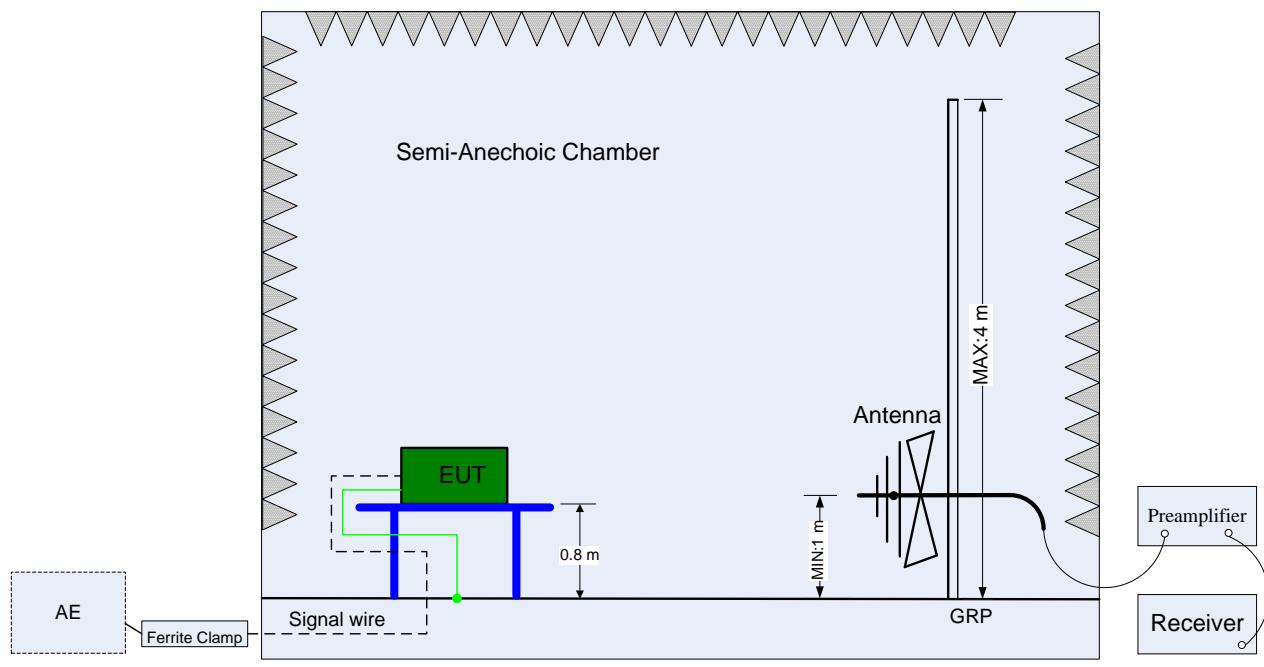
The Bluetooth component's antenna port(s) of the EUT are connected to the measurement instrument per an appropriate attenuator. The EUT is controlled by Bluetooth System Simulator and/or PC/software to emit the specified signals for the purpose of measurements.



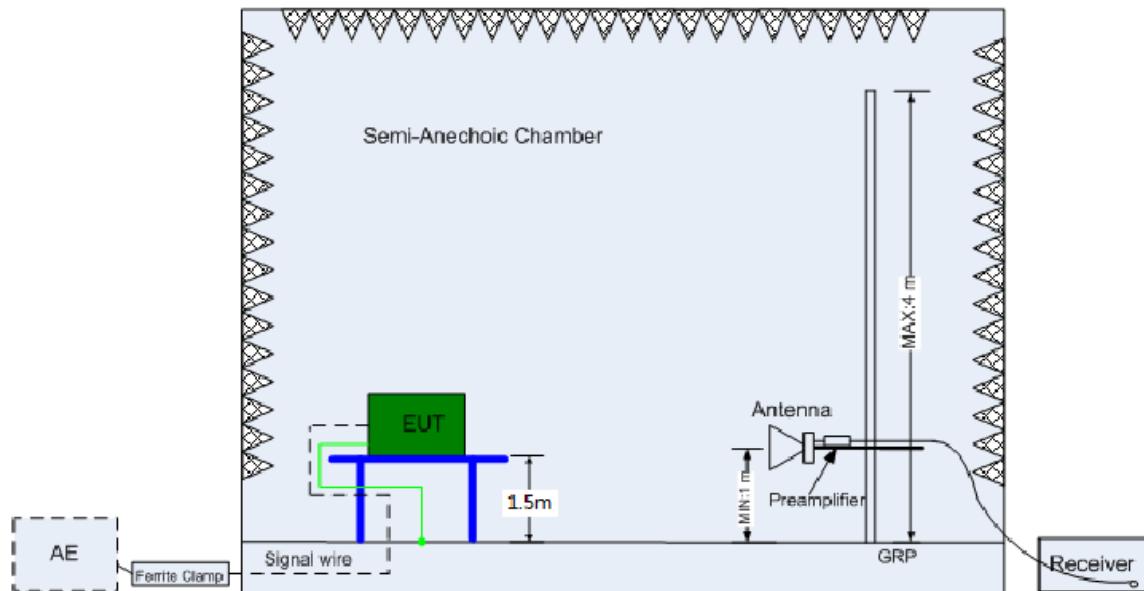
### 4.3.2 Test Setup 2

The test site semi-anechoic chamber has met the requirement of NSA tolerance 4 dB according to the standards: ANSI C63.4. The test distance is 3m. The setup is according to ANSI C63.4 and CAN/CSA-CEI/IEC CISPR 22.

The maximal emission value is acquired by adjusting the antenna height, polarisation and turntable azimuth. Normally, the height range of antenna is 1 m to 4 m, the azimuth range of turntable is 0° to 360°, and the receive antenna has two polarizations Vertical (V) and Horizontal (H).



(Below 1 GHz)

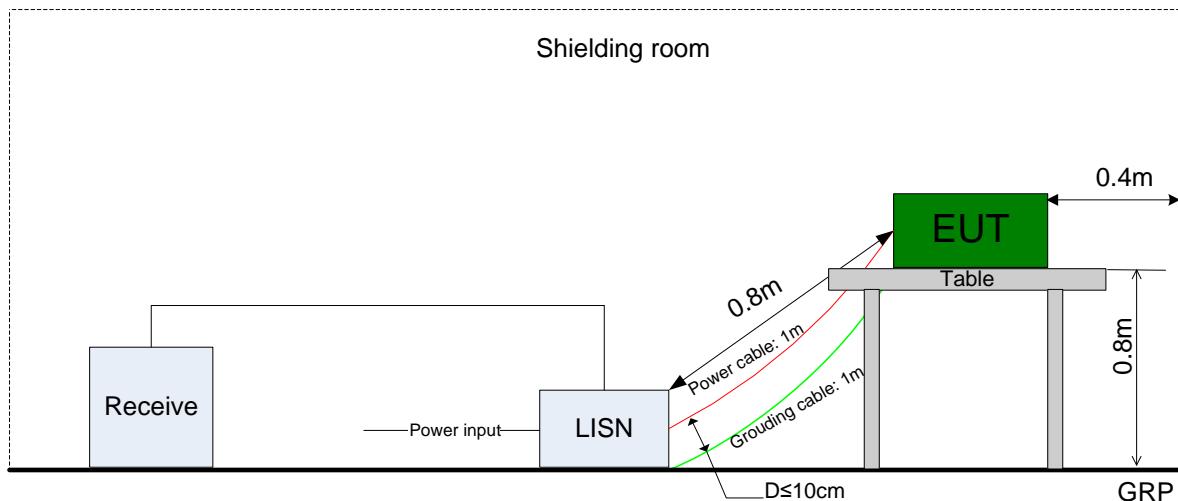


(Above 1 GHz)

#### 4.3.3 Test Setup 3

The mains cable of the EUT (maybe per AC/DC Adapter) must be connected to LISN. The LISN shall be placed 0.8 m from the boundary of EUT and bonded to a ground reference plane for LISN mounted on top of the ground reference plane. This distance is between the closest points of the LISN and the EUT. All other units of the EUT and associated equipment shall be at least 0.8m from the LISN.

Ground connections, where required for safety purposes, shall be connected to the reference ground point of the LISN and, where not otherwise provided or specified by the manufacturer, shall be of same length as the mains cable and run parallel to the mains connection at a separation distance of not more than 0.1 m.





#### 4.4 Test Conditions

Test Case	Test Conditions	
	Configuration	Description
6dB Emission Bandwidth (EBW)	Meas. Method	FCC KDB 558074 §8.1 Option 2.
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_Ch0, TM1_Ch19, TM1_Ch39.
Occupied Bandwidth	Meas. Method	FCC KDB 558074 §8.2 Option 2.
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_Ch0, TM1_Ch19, TM1_Ch39.
Maximum Conducted Average Output Power	Meas. Method	FCC KDB 558074 §9.2 .2. 4
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_Ch0, TM1_Ch19, TM1_Ch39.
Maximum Power Spectral Density Level	Meas. Method	FCC KDB 558074 §10.1
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_Ch0, TM1_Ch19, TM1_Ch39.
Band edge spurious emission	Meas. Method	FCC KDB 558074 §13.0.
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_Ch0, TM1_Ch39.
Unwanted Emissions into Non-Restricted Frequency Bands	Meas. Method	FCC KDB 558074 §11.0
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_Ch0, TM1_Ch19, TM1_Ch39.
Unwanted Emissions into Restricted Frequency Bands (Radiated)	Meas. Method	ANSI C63.10; FCC KDB 558074 §12.1, Radiated
	Test Env.	NTNV
	Test Setup	Test Setup 2
	EUT Conf.	30 MHz -1 GHz
		TM1_Ch0 (Worst Conf.).
		1-3 GHz
		TM1_Ch0, TM1_Ch19, TM1_Ch39.
	3-18 GHz	TM1_Ch19 (Worse Conf.),
		18-26.5 GHz
		TM1_Ch0 (Worst Conf.).
AC Power Line Conducted Emissions	Meas. Method	AC mains conducted. Pre: RBW = 10 kHz; Det. = Peak. Final: RBW = 9 kHz; Det. = CISPR Quasi-Peak & Average.
	Test Env.	NTNV
	Test Setup	Test Setup 3
	EUT Conf.	TM1_Ch39.



## 5 Main Test Instruments

Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal-Due
Power supply	KEITHLEY	2303	1342889	2015-09-16	2017-09-15
Wireless Communication Test set	Agilent	N4010A	MY49081592	2015-10-30	2016-10-29
Universal Radio Communication Tester	R&S	CMU200	123299	2015-10-30	2016-10-29
Spectrum Analyzer	Agilent	N9020A	MY52090652	2015-07-08	2016-07-07
Universal Radio Communication Tester	R & S	CMW500	126854	2016-01-08	2017-01-07
Spectrum Analyzer	Agilent	E4440A	MY48250119	2015-07-08	2016-07-07
Signal Analyzer	R&S	FSQ31	200021	2015-10-30	2016-10-29
Spectrum Analyzer	Agilent	N9030A	MY49431698	2015-10-30	2016-10-29
Temperature Chamber	WEISS	WKL64	56246002940010	2016-01-21	2017-01-20
Signal generator	Agilent	E8257D	MY49281095	2015-10-30	2016-10-29
Vector Signal Generator	R&S	SMU200A	104162	2015-10-30	2016-10-29
Test receiver	R&S	ESU26	100387	2015-6-24	2016-06-23
Test receiver	R&S	ESCI	101163	2015-6-24	2016-06-23
Spectrum analyzer	R&S	FSU3	200474	2015-06-15	2016-06-14
Spectrum analyzer	R&S	FSU43	100144	2015-06-15	2016-06-14
LOOP Antennas(9kHz-30MHz)	R&S	HFH2-Z2	100262	2015-4-30	2017-4-29
LOOP Antennas(9kHz-30MHz)	R&S	HFH2-Z2	100263	2015-4-30	2017-4-29
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBEC K	VULB 9163	9163-490	2015-4-30	2017-4-29
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBEC K	VULB 9163	9163-520	2015-4-30	2017-4-29
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	2015-4-30	2017-4-29
double ridged horn antenna (0.8G-18GHz)	R&S	HF907	100305	2015-4-30	2017-4-29
Pyramidal Horn Antenna(18GHz-26.5GHz)	ETS-Lindgren	3160-09	5140299	2015-7-15	2017-7-14
Artificial Main Network	R&S	ENV4200	100134	2015-6-24	2016-6-23
Line Impedance Stabilization Network	R&S	ENV216	100382	2015-6-24	2016-6-23
Signal Generator	Agilent	E4438C	MY49071538	2015-03-10	2016-03-09
Power Detecting & Sampling Unit	R&S	OSP-B157	100914	2015-07-27	2016-07-26